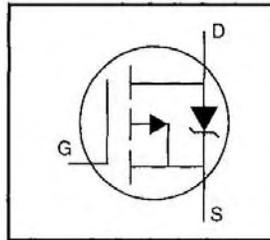


# IRFR9120PbF IRFU9120PbF

HEXFET® Power MOSFET

- Dynamic dv/dt Rating
- Repetitive Avalanche Rated
- Surface Mount (IRFR9120)
- Straight Lead (IRFU9120)
- Available in Tape & Reel
- P-Channel
- Fast Switching
- Lead-Free

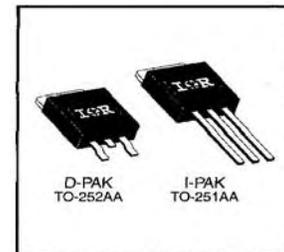


$V_{DSS} = -100V$
$R_{DS(on)} = 0.60\Omega$
$I_D = -5.6A$

**Description**

Third Generation HEXFETs from International Rectifier provide the designer with the best combination of fast switching, ruggedized device design, low on-resistance and cost-effectiveness.

The D-Pak is designed for surface mounting using vapor phase, infrared, or wave soldering techniques. The straight lead version (IRFU series) is for through-hole mounting applications. Power dissipation levels up to 1.5 watts are possible in typical surface mount applications.



**Absolute Maximum Ratings**

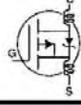
	Parameter	Max.	Units
$I_D @ T_C = 25^\circ C$	Continuous Drain Current, $V_{GS} @ -10 V$	-5.6	A
$I_D @ T_C = 100^\circ C$	Continuous Drain Current, $V_{GS} @ -10 V$	-3.6	
$I_{DM}$	Pulsed Drain Current ①	-22	
$P_D @ T_C = 25^\circ C$	Power Dissipation	42	W
$P_D @ T_A = 25^\circ C$	Power Dissipation (PCB Mount)**	2.5	
	Linear Derating Factor	0.33	W/°C
	Linear Derating Factor (PCB Mount)**	0.020	
$V_{GS}$	Gate-to-Source Voltage	$\pm 20$	V
$E_{AS}$	Single Pulse Avalanche Energy ②	210	mJ
$I_{AR}$	Avalanche Current ①	-5.6	A
$E_{AR}$	Repetitive Avalanche Energy ①	4.2	mJ
dv/dt	Peak Diode Recovery dv/dt ③	-5.5	V/ns
$T_J, T_{STG}$	Junction and Storage Temperature Range	-55 to +150	°C
	Soldering Temperature, for 10 seconds	260 (1.6mm from case)	

**Thermal Resistance**

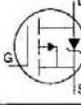
	Parameter	Min.	Typ.	Max.	Units
$R_{\theta JC}$	Junction-to-Case	—	—	3.0	°C/W
$R_{\theta JA}$	Junction-to-Ambient (PCB mount)**	—	—	50	
$R_{\theta JA}$	Junction-to-Ambient	—	—	110	

\*\* When mounted on 1" square PCB (FR-4 or G-10 Material).  
 For recommended footprint and soldering techniques refer to application note #AN-994.

## Electrical Characteristics @ $T_J = 25^\circ\text{C}$ (unless otherwise specified)

	Parameter	Min.	Typ.	Max.	Units	Test Conditions
$V_{(BR)DSS}$	Drain-to-Source Breakdown Voltage	-100	—	—	V	$V_{GS}=0V, I_D=-250\mu A$
$\Delta V_{(BR)DSS}/\Delta T_J$	Breakdown Voltage Temp. Coefficient	—	-0.098	—	V/°C	Reference to $25^\circ\text{C}$ , $I_D=-1mA$
$R_{DS(on)}$	Static Drain-to-Source On-Resistance	—	—	0.60	$\Omega$	$V_{GS}=-10V, I_D=-3.4A$ ④
$V_{GS(th)}$	Gate Threshold Voltage	-2.0	—	-4.0	V	$V_{DS}=V_{GS}, I_D=-250\mu A$
$g_{fs}$	Forward Transconductance	1.5	—	—	S	$V_{DS}=-50V, I_D=-3.4A$ ④
$I_{DSS}$	Drain-to-Source Leakage Current	—	—	-100	$\mu A$	$V_{DS}=-100V, V_{GS}=0V$
		—	—	-500		$V_{DS}=-80V, V_{GS}=0V, T_J=125^\circ\text{C}$
$I_{GSS}$	Gate-to-Source Forward Leakage	—	—	-100	nA	$V_{GS}=-20V$
	Gate-to-Source Reverse Leakage	—	—	100		$V_{GS}=20V$
$Q_g$	Total Gate Charge	—	—	18	nC	$I_D=-6.8A$
$Q_{gs}$	Gate-to-Source Charge	—	—	3.0		$V_{DS}=-80V$
$Q_{gd}$	Gate-to-Drain ("Miller") Charge	—	—	9.0		$V_{GS}=-10V$ See Fig. 6 and 13 ④
$t_{d(on)}$	Turn-On Delay Time	—	9.6	—	ns	$V_{DD}=-50V$
$t_r$	Rise Time	—	29	—		$I_D=-6.8A$
$t_{d(off)}$	Turn-Off Delay Time	—	21	—		$R_G=18\Omega$
$t_f$	Fall Time	—	25	—		$R_D=7.1\Omega$ See Figure 10 ④
$L_D$	Internal Drain Inductance	—	4.5	—	nH	Between lead, 6 mm (0.25in.) from package and center of die contact
$L_S$	Internal Source Inductance	—	7.5	—		
$C_{iss}$	Input Capacitance	—	390	—	pF	$V_{GS}=0V$
$C_{oss}$	Output Capacitance	—	170	—		$V_{DS}=-25V$
$C_{rss}$	Reverse Transfer Capacitance	—	45	—		$f=1.0MHz$ See Figure 5

## Source-Drain Ratings and Characteristics

	Parameter	Min.	Typ.	Max.	Units	Test Conditions
$I_S$	Continuous Source Current (Body Diode)	—	—	-5.6	A	MOSFET symbol showing the integral reverse p-n junction diode. 
$I_{SM}$	Pulsed Source Current (Body Diode) ①	—	—	-22		
$V_{SD}$	Diode Forward Voltage	—	—	-6.3	V	$T_J=25^\circ\text{C}, I_S=-5.6A, V_{GS}=0V$ ④
$t_{rr}$	Reverse Recovery Time	—	100	200	ns	$T_J=25^\circ\text{C}, I_F=-6.8A$
$Q_{rr}$	Reverse Recovery Charge	—	0.33	0.66	$\mu C$	$di/dt=100A/\mu s$ ④
$t_{on}$	Forward Turn-On Time	Intrinsic turn-on time is negligible (turn-on is dominated by $L_S+L_D$ )				

### Notes:

- ① Repetitive rating; pulse width limited by max. junction temperature (See Figure 11)
- ②  $V_{DD}=-25V$ , starting  $T_J=25^\circ\text{C}$ ,  $L=10mH$ ,  $R_G=25\Omega$ ,  $I_{AS}=-5.6A$  (See Figure 12)
- ③  $I_{SD}=-6.8A$ ,  $di/dt \leq 110A/\mu s$ ,  $V_{DD} \leq V_{(BR)DSS}$ ,  $T_J \leq 150^\circ\text{C}$
- ④ Pulse width  $\leq 300\mu s$ ; duty cycle  $\leq 2\%$ .

